

SEMICONDUCTOR®

December 2013

FQP8N80C / FQPF8N80C / FQPF8N80CYDTU **N-Channel QFET® MOSFET**

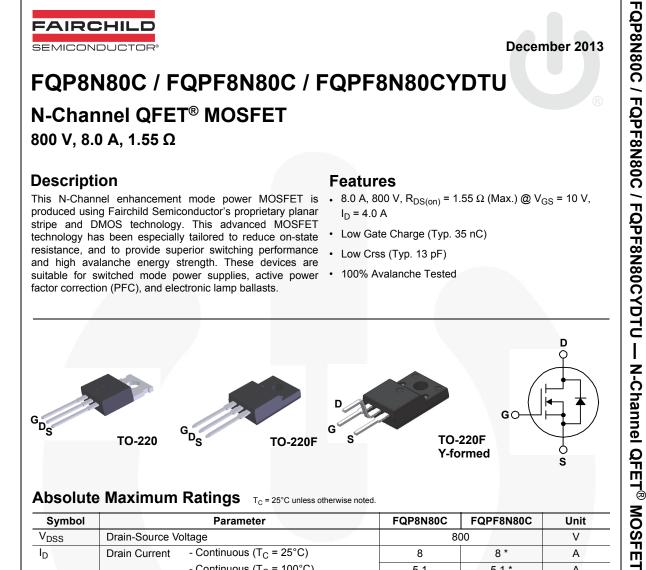
800 V, 8.0 A, 1.55 Ω

Description

This N-Channel enhancement mode power MOSFET is • 8.0 A, 800 V, R_{DS(on)} = 1.55 Ω (Max.) @ V_{GS} = 10 V, produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state . Low Gate Charge (Typ. 35 nC) resistance, and to provide superior switching performance • Low Crss (Typ. 13 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power • 100% Avalanche Tested factor correction (PFC), and electronic lamp ballasts.

Features

- $I_{D} = 4.0 \text{ A}$



Absolute Maximum Ratings T_c = 25°C unless otherwise noted.

Symbol	Parameter		FQP8N80C	FQPF8N80C	Unit
V _{DSS}	Drain-Source Voltage	8	00	V	
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$)	8	8 *	А	
	- Continuous (T _C = 100°C)	-	5.1	5.1 *	А
I _{DM}	Drain Current - Pulsed	(Note 1)	32	32 *	А
V _{GSS}	Gate-Source Voltage	± 30		V	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	850		mJ
I _{AR}	Avalanche Current	(Note 1)		8	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	17.8		mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5		V/ns
PD	Power Dissipation (T _C = 25°C)		178	59	W
	- Derate above 25°C	1.43	0.48	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150		°C	
TI	Maximum lead temperature for soldering,	3	00	°C	
۰L	1/8" from case for 5 seconds	3	C		

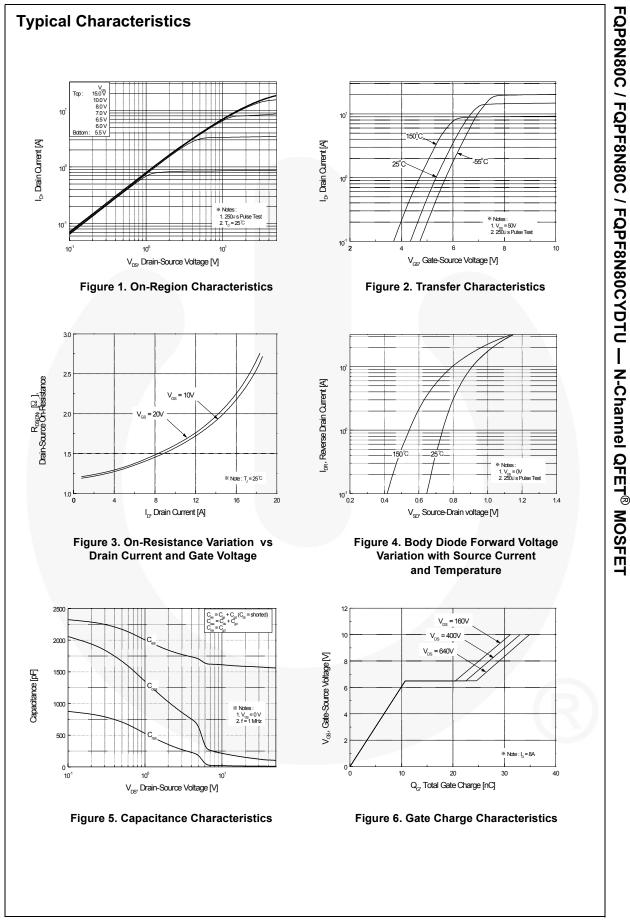
Thermal Characteristics

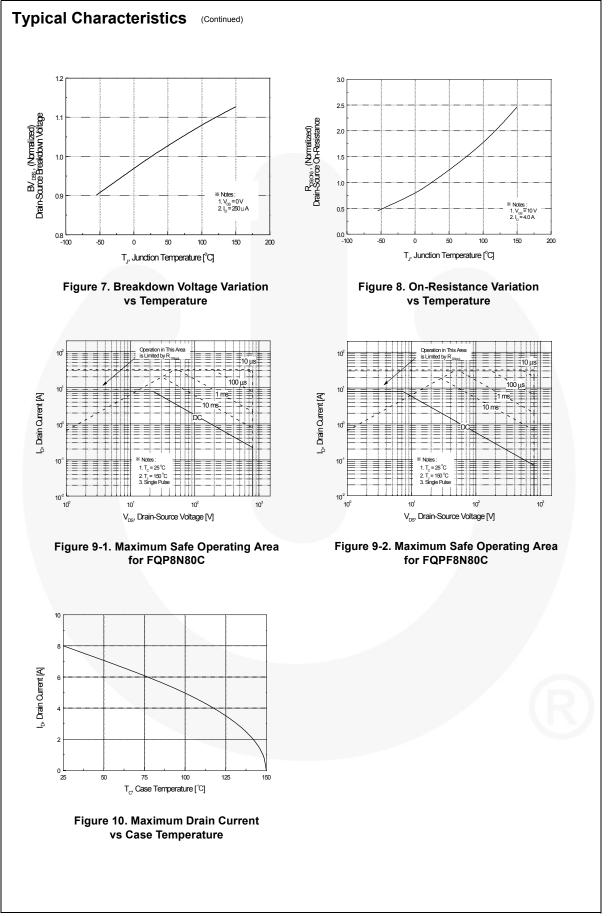
Symbol	Parameter	FQP8N80C	FQPF8N80C	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.89	2.66	°C/W	
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ, Max.	0.5		°C/W	
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient, Max.	62.5	62.5	°C/W	

Part NumberTop MarkFQP8N80CFQP8N80CFQPF8N80CFQPF8N80CFQPF8N80CYDTUFQPF8N80C		Top Mark	k Pack		v		Reel S	Size	Tape Width N/A		Quantity 50 units	
				220			N//	٩				
				220F Tube N/A		4	N/A		50 units			
		TO-220F Tube N/. (Y-formed)		A N/A			50 units					
lectric	cal Char	acteristics	T _C = 25°0	C unless oth	erwise noted.							
Symbol Parameter		Test Conditions			Min.	Тур.	Max.	Unit				
Off Cha	aracteristi	cs										
BV _{DSS}	1			V _{GS} = 0 V, I _D = 250 μA			800			V		
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient		$I_D = 250 \ \mu$ A, Referenced to 25°C				0.5		V/°C			
			V _{DS} = 800 V, V _{GS} = 0 V					10	μA			
	∠ero Gate	Zero Gate Voltage Drain Current		$V_{\rm DS} = 640 \text{ V}, \text{ T}_{\rm C} = 125^{\circ}\text{C}$				1		100	μΑ	
I _{GSSF}	Gate-Body	Gate-Body Leakage Current, Forward		V _{GS} = 30 V, V _{DS} = 0 V			1			100	nA	
I _{GSSR}				$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$						-100	nA	
On Characteristics			V -	V _{GS} , I _D = 25	00		2.0		5.0	V		
V _{GS(th)}		shold Voltage	_	v _{DS} –	v _{GS} , I _D – 20	υ μΑ		3.0		5.0	V	
R _{DS(on)}	On-Resista			$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 4 \text{ A}$ $V_{DS} = 50 \text{ V}, \text{ I}_{D} = 4 \text{ A}$ (Note 4)			-	1.29	1.55	Ω		
9fs	Forward Tr	ansconductance	_	$V_{DS} =$	50 V, I _D = 4 /	4	(Note 4)		5.6		S	
Dynami	ic Charac	toristics										
C _{iss}	Input Capa		_	V _{DS} = 25 V, V _{GS} = 0 V,				1580	2050	pF		
C _{oss}	Output Cap			f = 1.0		U V,			135	175	pF	
C _{rss}		ansfer Capacitance	Э	1 1.0	WIT 12				13	17	pF	
			_									
Switchi	ing Chara	cteristics										
t _{d(on)}	Turn-On De	,		V _{DD} =	400 V, I _D = 8	3 A,			40	90	ns	
tr	Turn-On Ri			R _G = 2	_				110	230	ns	
t _{d(off)}	Turn-Off De	,					ata (E)		65	140	ns	
^t f	Turn-Off Fa						ote 4, 5)		70	150	ns	
Qg	Total Gate				640 V, I _D = 8	3 A,			35	45	nC	
Q _{gs}	Gate-Source	0		V _{GS} = 10 V				10		nC		
Q _{gd}	Gate-Drain	Charge				(N	ote 4, 5)		14		nC	
		de Cherreteri	otion	ad Ma-		tinge						
	1	ode Characteri				tings				0	٨	
ls		Maximum Continuous Drain-Source Did Maximum Pulsed Drain-Source Diode F								8 32	A	
			Forward Current						A V			
V _{SD}		ce Diode Forward	vollage		0 V, I _S = 8 A 0 V, I _S = 8 A			-		1.4		
t _{rr}		ecovery Time			υ ν, ι _S = 8 Α = 100 Α/μs		(Note 4)		690 8 2		ns	
Q _{rr}	Reverse R	ecovery Charge		urF / ut	- 100 A/μS		(110184)		8.2		μC	

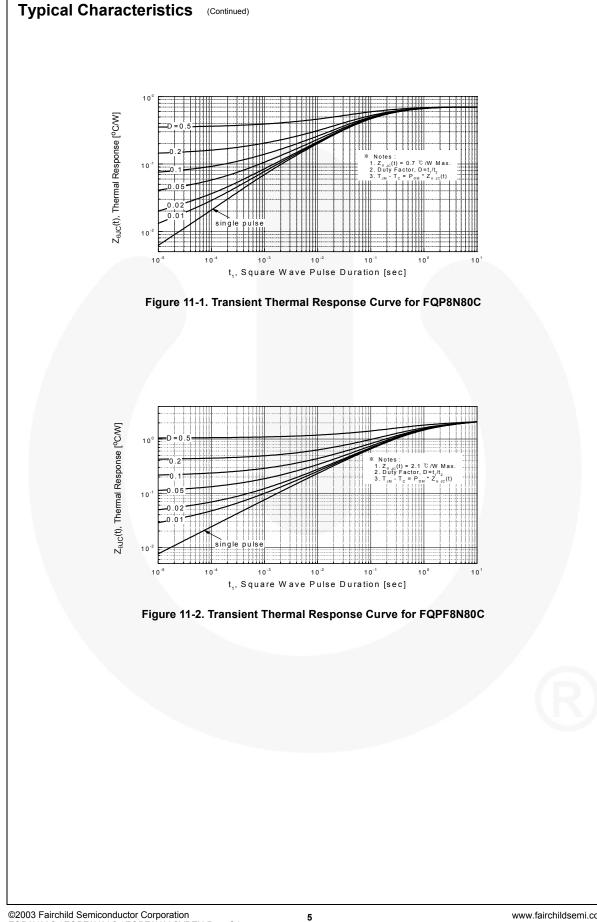
1. Repetitive rating : pulse-width limited by maximum junction tempe 2. L = 25 mH, I_{AS} = 8 A, V_{DD} = 50 V, R_G = 25 Ω, starting T_J = 25°C. 3. I_{SD} ≤ 8 A, di/dt ≤ 200 A/µs, V_{DD} ≤ BV_{DSS}, starting T_J = 25°C. 4. Pulse test : pulse-width ≤ 300 µs, duty cycle ≤ 2%. 5. Essentially independent of operating temperature.

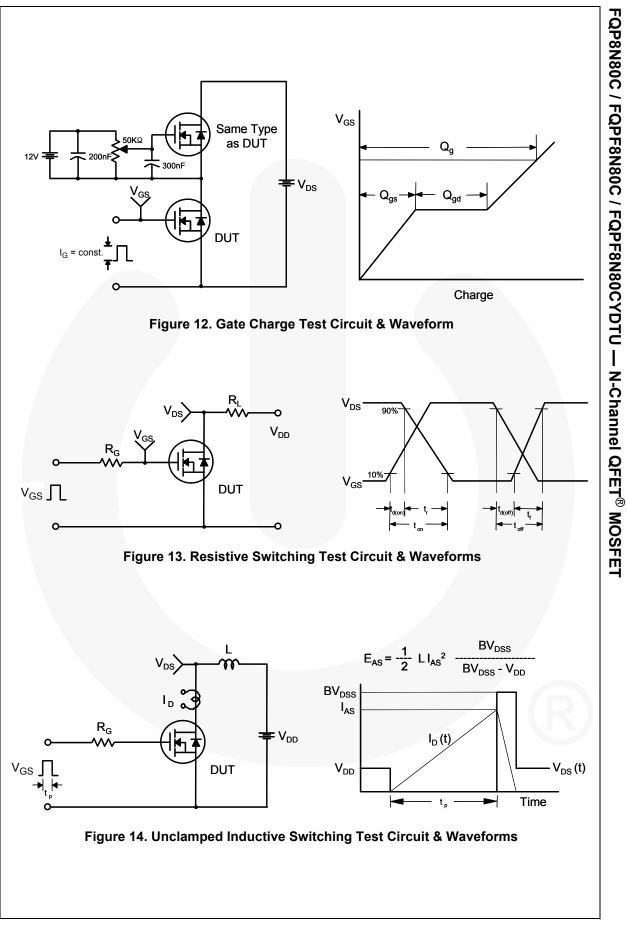
FQP8N80C / FQPF8N80C / FQPF8N80CYDTU — N-Channel QFET® MOSFET

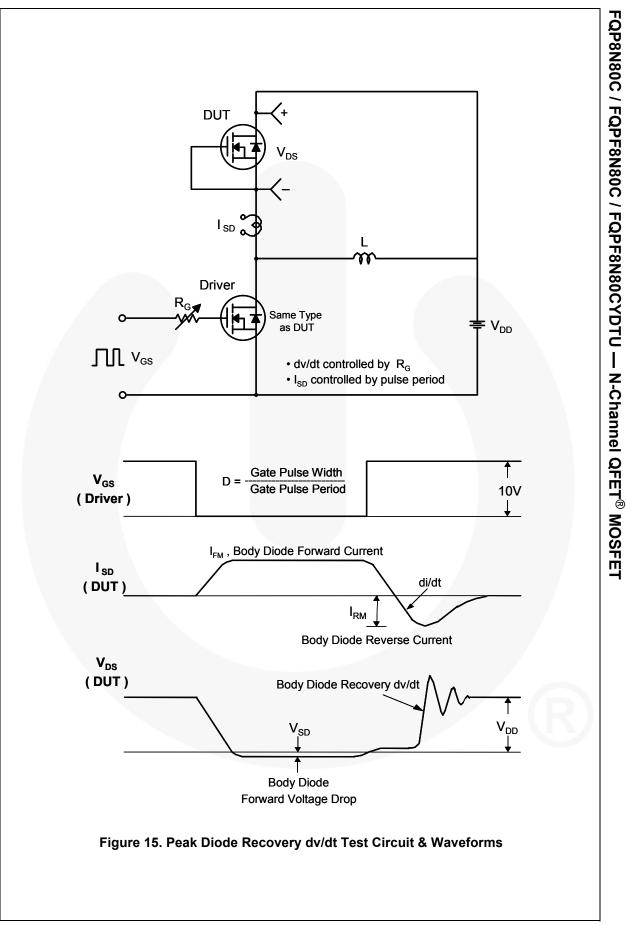


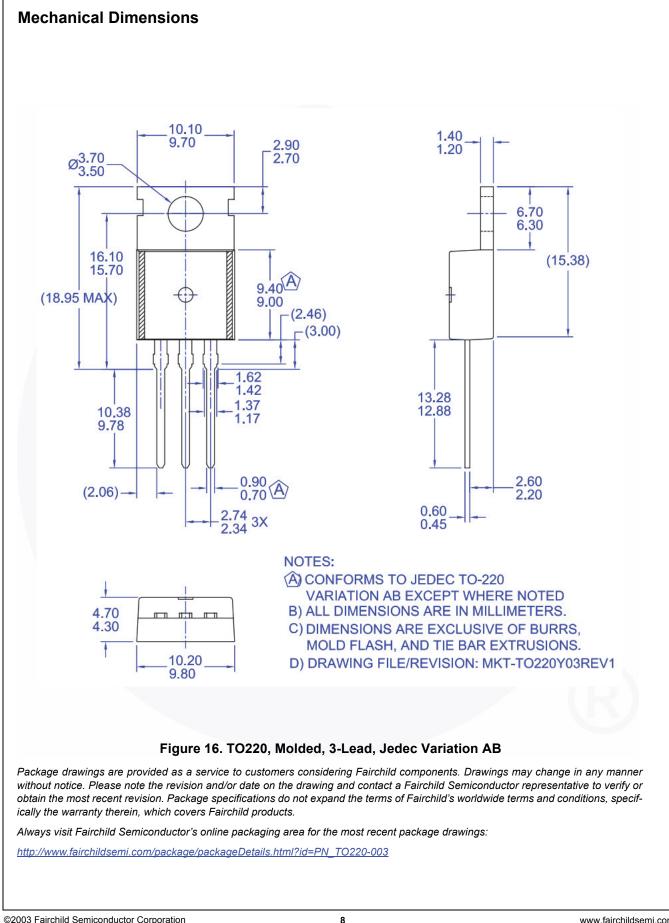


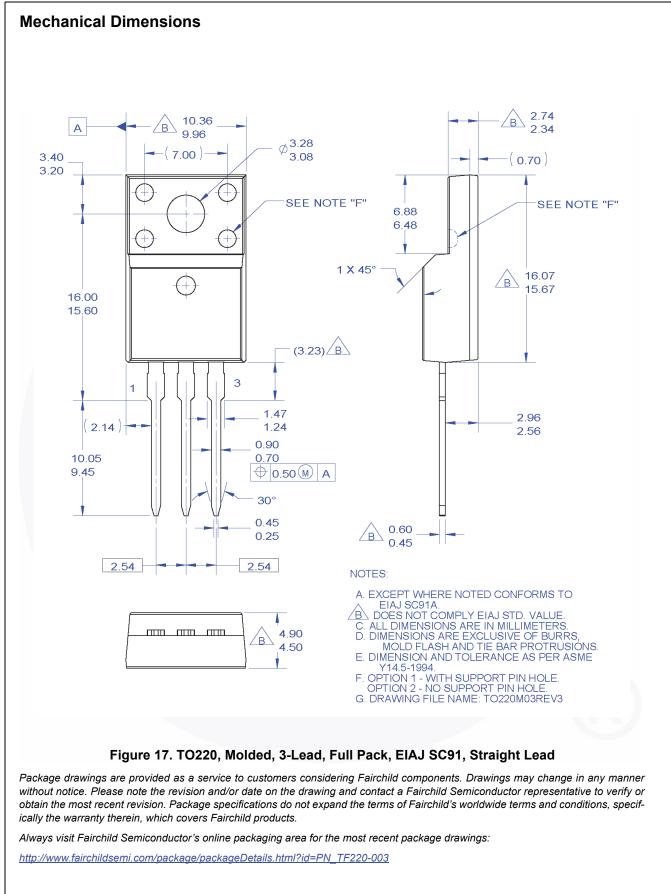
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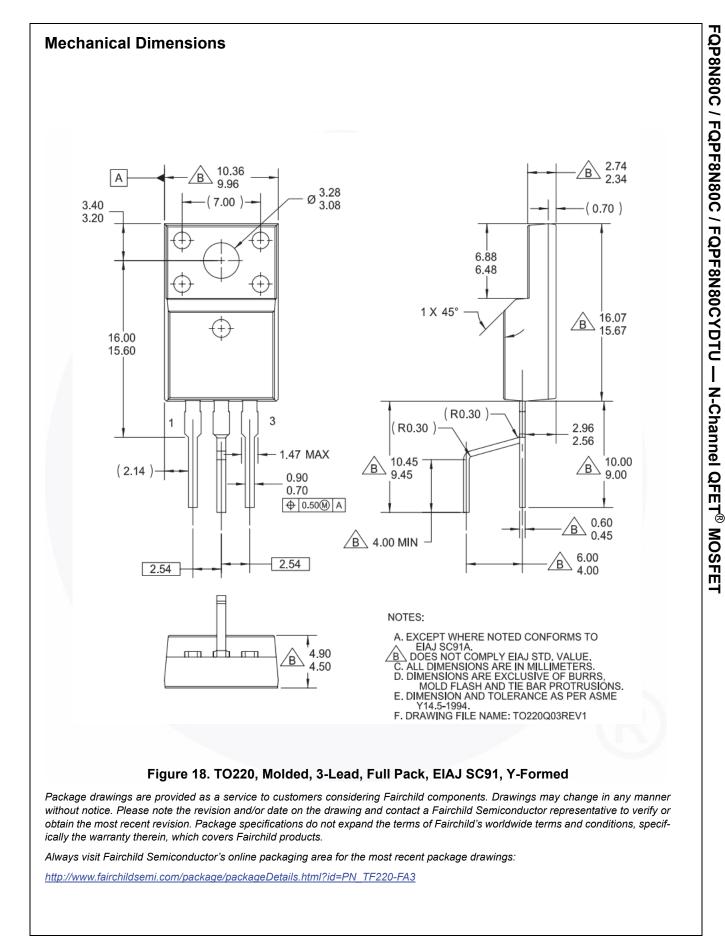














notice to improve design.

11

Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.

Datasheet contains specifications on a product that is discontinued by Fairchild

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Full Production

Not In Production

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